

Search Notes

Application/Control No.

10/785,200

Examiner

Yoon-Young Kim

Applicant(s)/Patent under
Reexamination

HAUVILLE, FRANCOIS P.

Art Unit

1723

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|----------|------|
| Inventor Search | 2/3/2006 | YK |
| See EAST Search History 210/232,323.1,323.2,423,253,321.75 | 2/6/2006 | YK |
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